

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/651,663	XIE, FEI	
				Examiner	Art Unit	
				Yuwen Pan	2682	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
415	412.1 412.2 050.1	10/1/05	YU	Lewis West	10/1/05	YU
	556.2					
707	205					
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			
See search history	2/13/07	YU				